

# BRIGHT LED ELECTRONICS CORP.

## LED LAMPS SPECIFICATION

●COMMODITY : 2.1x6.9x7.7mm1.0”Lead Rectangular

PAGE: 2

●DEVICE NUMBER : BL-R5132K

VERSION : 1.0

●ELECTRICAL AND OPTICAL CHARACTERISTICS (Ta=25°C)

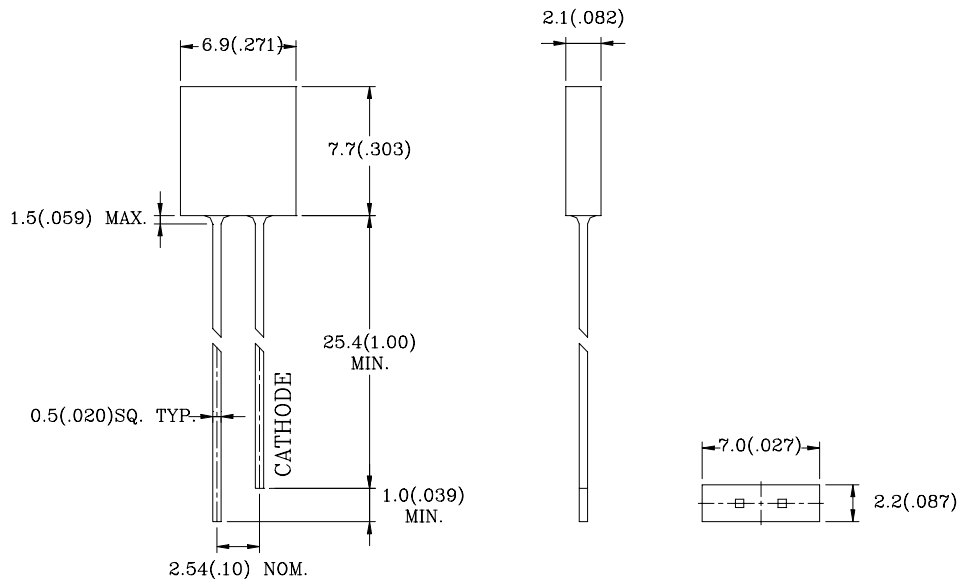
Chip		Lens  Appearance	Absolute Maximum Rating				Electro-optical Data (At 20mA)			Viewing Angle 2 θ 1/2 (deg)
Emitted Color	Peak Wave Length λ P(nm)		Δ λ (nm)	Pd (mW)	If (mA)	Peak If(mA)	Vf(V)		Iv (mcd) Typ.	
							Typ.	Max.		
Bright Red	700	Red Diffused	100	40	15	50	2.2	2.6	0.5	160

Remark : Viewing angle is the Off-axis angle at which the luminous intensity is half the axial luminous intensity.

●ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Reverse Voltage .....	5V
Reverse Current (VR=5V) .....	100μA
Operating Temperature Range .....	-40°C ~ 80°C
Storage Temperature Range .....	-40°C ~ 85°C
Lead Soldering Temperature .....	260°C For 5 Seconds

●PACKAGE DIMENSIONS



NOTES: 1.All dimensions are in millimeters (inches).

2.Tolerance is ± 0.25mm (0.01”) unless otherwise specified.

3.Lead spacing is measured where the leads emerge from the package.

4.Specifications are subject to change without notice.

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PAGE: 3  
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Fig.1 RELATIVE INTENSITY VS. WAVELENGTH

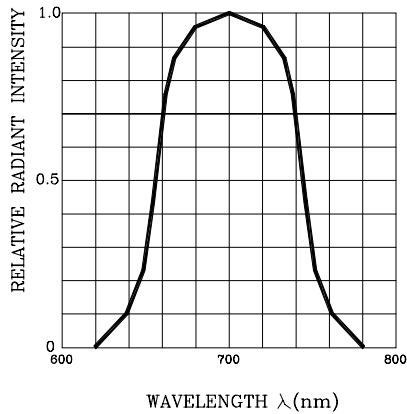


Fig.2 FORWARD CURRENT DERATING CURVE

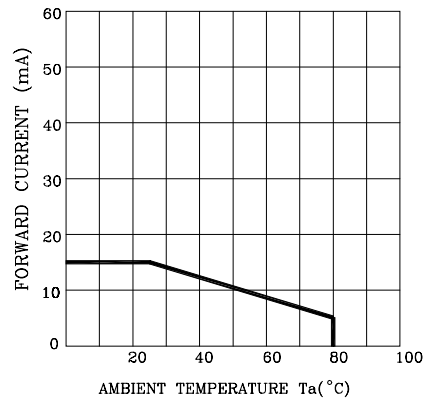


Fig.3 FORWARD CURRENT VS. FORWARD VOLTAGE

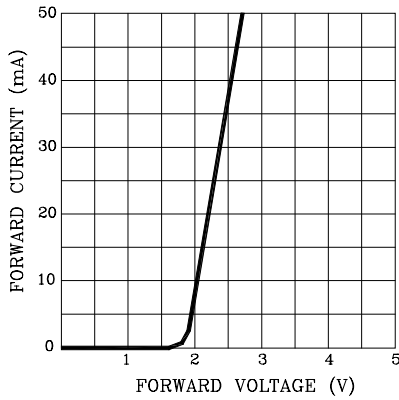


Fig.4 RELATIVE LUMINOUS INTENSITY VS. AMBIENT TEMPERATURE

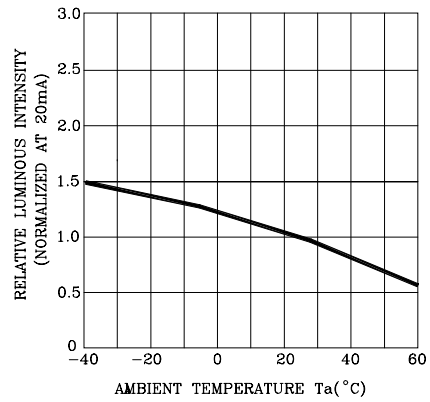
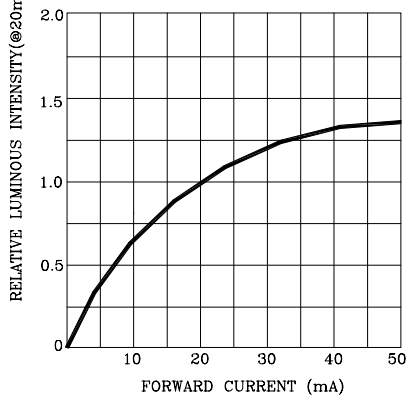
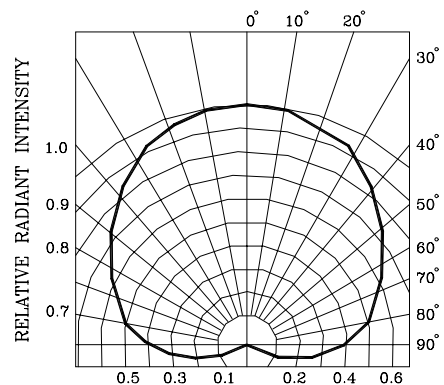


Fig.5 RELATIVE LUMINOUS INTENSITY VS. FORWARD CURRENT



RADIATION DIAGRAM



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### RELIABILITY TEST

PAGE: 4  
VERSION : 1.0

Classification	Test Item	Reference Standard	Test Conditions	Result
Endurance Test	Operation Life	MIL-STD-750:1026 MIL-STD-883:1005 JIS C 7021 :B-1	Connect with a power $I_f=20\text{mA}$ $T_a$ =Under room temperature Test time=1,000hrs	0/100
	High Temperature High Humidity Storage	MIL-STD-202:103B JIS C 7021 :B-11	$T_a=85^\circ\text{C} \pm 5^\circ\text{C}$ RH=90%-95% Test time=240hrs	0/100
	High Temperature Storage	MIL-STD-883:1008 JIS C 7021 :B-10	High $T_a=105^\circ\text{C} \pm 5^\circ\text{C}$ Test time=1,000hrs	0/100
	Low Temperature Storage	JIS-C-7021 :B-12	Low $T_a=-55^\circ\text{C} \pm 5^\circ\text{C}$ Test time=1,000hrs	0/100
Environmental Test	Temperature Cycling	MIL-STD-202:107D MIL-STD-750:1051 MIL-STD-883:1010 JIS C 7021 :A-4	$-55^\circ\text{C} \sim 25^\circ\text{C} \sim 105^\circ\text{C} \sim 25^\circ\text{C}$ 30min 5min 30min 5min Test Time=10cycle	0/100
	Thermal Shock	MIL-STD-202:107D MIL-STD-750:1051 MIL-STD-883:1011	$-55^\circ\text{C} \pm 5^\circ\text{C} \sim 105^\circ\text{C} \pm 5^\circ\text{C}$ 10min 10min Test Time=10cycle	0/100
	Solder Resistance	MIL-STD-202:201A MIL-STD-750:2031 JIS C 7021 :A-1	$T_{\text{sol}}=260 \pm 5^\circ\text{C}$ Dwell Time= $5 \pm 1$ sec.	0/50
	Solder ability	MIL-STD-202:208D MIL-STD-750:2026 MIL-STD-883:2003 JIS C 7021 :A-2	$T_{\text{sol}}=230 \pm 5^\circ\text{C}$ Dwell Time= $5 \pm 1$ sec.	0/50
	Lead Bending Stress	MIL-STD-750:2036 JIS C 7021 :A-11	$0^\circ \sim 90^\circ \sim 0^\circ$ bend , 3 cycles Weight 250g	0/50

#### JUDGMENT CRITERIA OF FAILURE FOR THE RELIABILITY

Measuring items	Symbol	Measuring conditions	Judgement criteria for failure
Forward voltage	$V_F$	$I_f=20\text{mA}$	Over $U_x1.2$
Reverse current	$I_r$	$V_r=5\text{V}$	Over $U_x2$
Luminous intensity	$I_v$	$I_f=20\text{mA}$	Below $S_x0.5$

Notes: 1.U means the upper limit of specified characteristics. S means initial value.

2.Measurment shall be taken between 2 hours and after the test pieces have been returned to normal ambient conditions after completion of each test.